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- EPIC TM (Enhanced-Performance Implanted CMOS) Submicron Process
- Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, Ceramic Chip Carriers (FK) and Flatpacks (W), and Standard Plastic (N) and Ceramic (J) DIPS

description

The 'AC14 contain six independent inverters. The devices perform the Boolean function $Y = \overline{A}$.

The SN54AC14 is characterized for operation over the full military temperature range of -55° C to 125° C. The SN74AC14 is characterized for operation from -40° C to 85° C.

| FUNCTION TABLE (each inverter) | | | | | | | |
|-----------------------------------|-------------|--|--|--|--|--|--|
| INPUT A | OUTPUT Y | | | | | | |
| Н | L | | | | | | |
| L | Н | | | | | | |

| SN54AC14 J OR W PACKAGE |
|----------------------------------|
| SN74AC14 D, DB, N, OR PW PACKAGE |
| (TOP VIEW) |
| |

| 1A [1Y [| 1 2 | U | 14 13 |] V _{CC}] 6A |
|--------------|--------|---|----------|---------------------------|
| 2A [| 3 | | 12 |] 6Y |
| 2Y [3A [| 4 | | 11 | 5A |
| 3A [| 5 | | 10 | _ 5Y |
| 3Y [| 6 | | 9 |] 4A |
| GND [| 7 | | 8 |] 4Y |

SN54AC14 ... FK PACKAGE (TOP VIEW)



NC - No internal connection

logic diagram, each inverter (positive logic)



logic symbol[†]

| 1 A | 1 | п | 2 1Y |
|-----|----|---|------------|
| 1A | 3 | | 4 |
| 2A | 5 | | 2Y |
| 3A | | | <u> </u> |
| 4A | 9 | | ← <u> </u> |
| | 11 | | 10 5Y |
| 5A | 13 | | 12 |
| 6A | | | 6Y |

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, DB, J, N, PW, or W packages.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

| Ν | $\begin{array}{cccc} -0.5 \mbox{ V to } V_{CC} + 0.5 \mbox{ V} \\0.5 \mbox{ V to } V_{CC} + 0.5 \mbox{ V} \\ \pm 20 \mbox{ mA} \\ \pm 20 \mbox{ mA} \\ \pm 50 \mbox{ mA} \\ \pm 200 \mbox{ mA} \end{array}$ |
|---|---|
| Storage temperature range, T _{stg} | |

⁺ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils, except for the N package, which has a trace length of zero.

recommended operating conditions (see Note 3)

| | | | SN54/ | SN54AC14 | | SN74AC14 | | |
|---------------------|------------------------------------|-------------------------|-------|----------|-----|----------|------|--|
| | | | MIN | MAX | MIN | MAX | UNIT | |
| VCC | Supply voltage | | 2 | 6 | 2 | 6 | V | |
| VI | Input voltage | | 0 | VCC | 0 | VCC | V | |
| Vo | Output voltage | | 0 | VCC | 0 | VCC | V | |
| Iон | High-level output current | $V_{CC} = 3 V$ | | -12 | | -12 | | |
| | | $V_{CC} = 4.5 V$ | | -24 | | -24 | mA | |
| | | V _{CC} = 5.5 V | | -24 | | -24 | | |
| | | $V_{CC} = 3 V$ | | 12 | | 12 | | |
| IOL | Low-level output current | $V_{CC} = 4.5 V$ | | 24 | | 24 | mA | |
| | V _{CC} = 5.5 V | | | 24 | | 24 | | |
| $\Delta t/\Delta v$ | Input transition rise or fall rate | | 0 | 8 | 0 | 8 | ns/V | |
| TA | Operating free-air temperature | | -55 | 125 | -40 | 85 | °C | |

NOTE 3: Unused inputs must be held high or low to prevent them from floating.



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| | TEST CONDITIONS | V | Т | A = 25°C | ; | SN54 | 54AC14 SN74AC14 | | UNIT | |
|--------------------------------------|---|-------|------|----------|------|------|-----------------|------|------|------|
| PARAMETER | TEST CONDITIONS | Vcc | MIN | TYP | MAX | MIN | MAX | MIN | MAX | UNIT |
| V _{T+} | | 3 V | 0.8 | 1.8 | 2.2 | 0.8 | 2.2 | 0.8 | 2.2 | V |
| Positive-going | | 4.5 V | 1.5 | 2.6 | 3.2 | 1.5 | 3.2 | 1.5 | 3.2 | |
| threshold | | 5.5 V | 1.6 | 3.2 | 3.9 | 1.6 | 3.9 | 1.6 | 3.9 | |
| V _T _ | | 3 V | 0.5 | 0.8 | 1 | 0.5 | 1 | 0.5 | 1 | |
| Negative-going | | 4.5 V | 0.9 | 1.4 | 1.8 | 0.9 | 1.8 | 0.9 | 1.8 | V |
| threshold | | 5.5 V | 1.1 | 1.8 | 2.3 | 1.1 | 2.3 | 1.1 | 2.3 | |
| ΔVτ | | 3 V | 0.3 | 1 | 1.2 | 0.3 | 1.2 | 0.3 | 1.2 | |
| Hysteresis | | 4.5 V | 0.4 | 1.2 | 1.4 | 0.4 | 1.4 | 0.4 | 1.4 | V |
| (V _{T+} – V _{T–}) | | 5.5 V | 0.5 | 1.4 | 1.6 | 0.5 | 1.6 | 0.5 | 1.6 | |
| | | 3 V | 2.9 | | | 2.9 | | 2.9 | | |
| | I _{OH} = - 50 μA | 4.5 V | 4.4 | | | 4.4 | | 4.4 | | |
| | | 5.5 V | 5.4 | | | 5.4 | | 5.4 | | |
| | I _{OH} = – 12 mA | 3 V | 2.56 | | | 2.4 | | 2.48 | | |
| VOH | | 4.5 V | 3.86 | | | 3.7 | | 3.8 | | |
| | I _{OH} = – 24 mA | 5.5 V | 4.86 | | | 4.7 | | 4.8 | | |
| | I _{OH} = - 50 mA [†] | 5.5 V | | | | 3.85 | | | | |
| | I _{OH} = - 75 mA [†] | 5.5 V | | | | | | 3.85 | | |
| | | 3 V | | 0.002 | 0.1 | | 0.1 | | 0.1 | |
| | I _{OL} = 50 μA | 4.5 V | | 0.001 | 0.1 | | 0.1 | | 0.1 | |
| | | 5.5 V | | 0.001 | 0.1 | | 0.1 | | 0.1 | |
| | I _{OL} = 12 mA | 3 V | | | 0.36 | | 0.5 | | 0.44 | |
| VOL | | 4.5 V | | | 0.36 | | 0.5 | | 0.44 | |
| | I _{OL} = 24 mA | 5.5 V | | | 0.36 | | 0.5 | | 0.44 | |
| | I _{OL} = 50 mA [†] | 5.5 V | | | | | 1.65 | | | |
| | I _{OL} = 75 mA [†] | 5.5 V | | | | | | | 1.65 | |
| l | $V_{I} = V_{CC}$ or GND | 5.5 V | | | ±0.1 | | ±1 | | ±1 | μA |
| ICC | $V_{I} = V_{CC} \text{ or GND}, \qquad I_{O} = 0$ | 5.5 V | | | 2 | | 40 | | 20 | μA |
| Ci | VI = V _{CC} or GND | 5 V | | 4.5 | | | | | | pF |

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V $\pm\,$ 0.3 V (unless otherwise noted) (see Figure 1)

| 1 | PARAMETER | FROM TO | Т | ₄ = 25°C | ; | SN54/ | AC14 | SN74 | AC14 | UNIT | |
|---|------------------|---------|----------|-----------------|-----|-------|------|------|------|------|------|
| | FARAMETER | (INPUT) | (OUTPUT) | MIN | TYP | MAX | MIN | MAX | MIN | MAX | UNIT |
| | ^t PLH | ٨ | V | 1.5 | 6 | 13.5 | 1 | 16 | 1.5 | 15 | |
| | ^t PHL | A | T | 1.5 | 6 | 11.5 | 1 | 14 | 1.5 | 13 | ns |



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switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM | то | Т | ₄ = 25°C | ; | SN54 | AC14 | SN74 | AC14 | UNIT |
|------------------|---------|----------|-----|-----------------|-----|------|------|------|------|------|
| FARAMETER | (INPUT) | (OUTPUT) | MIN | TYP | MAX | MIN | MAX | MIN | MAX | |
| ^t PLH | A | V | 1.5 | 5 | 10 | 1.5 | 12 | 1.5 | 11 | |
| ^t PHL | | T | 1.5 | 5 | 8.5 | 1.5 | 10 | 1.5 | 9.5 | ns |

operating characteristics, V_{CC} = 5 V, T_A = 25° C

| PARAMETER | | TEST CONDITIONS | TYP | UNIT |
|-----------------------|-------------------------|---|-----|------|
| C _{pd} Power | dissipation capacitance | $C_L = 50 \text{ pF}, f = 1 \text{ MHz}$ | 25 | pF |

PARAMETER MEASUREMENT INFORMATION



NOTES: A. CL includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_f \leq 2.5 ns, t_f \leq 2.5 ns.
 - C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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